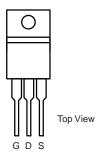


K3511-VB Datasheet N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY		
V _{DS}	80	V
$R_{DS(on)}$ $V_{GS} = 10$ V	7	mΩ
$R_{DS(on)}$ $V_{GS} = 4.5 V$	9	mΩ
I _D	100	А
Configuration	Sin	gle



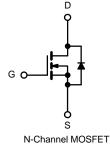


FEATURES

- Trench Power MOSFET
- + 100 $\%~\text{R}_{g}$ and UIS Tested

APPLICATIONS

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



ABSOLUTE MAXIMUM RATINGS (Γ _A = 25 °C, unless	s otherwise no	ted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	80	V	
Gate-Source Voltage		V _{GS}		± 20
Continuous Drain Current (T _J = 150 °C)	T _C = 25 °C		100ª	
	T _C = 70 °C		85 ^a	
	T _A = 25 °C	I _D	28.6 ^{b, c}	
	T _A = 70 °C		24.9 ^{b, c}	A
Pulsed Drain Current (t = 100 μs)		I _{DM} 35	350	A
Captinuous Source Drain Diade Current	T _C = 25 °C	I _S	80 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C		4.5 ^{b, c}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	30	
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	45	mJ
	T _C = 25 °C		180	
Maximum Power Dissipation	T _C = 70 °C	P _D	120	w
	T _A = 25 °C		5 ^{b, c}	vv
	T _A = 70 °C		3.2 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	0 °
Soldering Recommendations (Peak Temperature)		-	260	- °C

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Manimum handlan ta Ambianti	$t \le 10 \text{ sec}$	R _{thJA}	15	18			
Maximum Junction-to-Ambient ^a	Steady State		40	50	°C/W		
Maximum Junction-to-Case		R _{thJC}	0.85	1.1			

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.



K3511-VB

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	80			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 A		37		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μΑ		- 6.1		mV/°C
Gate-Source Threshold Voltage	V _{GS(th})	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2.0		3.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 80 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	85			Α
	_ (0.19	V _{GS} = 10 V, I _D = 20 A		7	1 1	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 6 V, I _D = 15 A		7.5		mΩ
		V _{GS} = 4.5 V, I _D = 10 A		9		
Forward Transconductance ^a	g _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$		60		S
Dynamic ^b				•	•	
Input Capacitance	C _{iss}			3855		pF
Output Capacitance	C _{oss}	V_{DS} = 40 V, V_{GS} = 0 V, f = 1 MHz		1120		
Reverse Transfer Capacitance	C _{rss}			376		
		$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		35.5		
Total Gate Charge	Qg	$V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		22		
				18		
Gate-Source Charge	Q _{gs}	$V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		5.3		nC
Gate-Drain Charge	Q _{gd}			7.3		
Output Charge	Q _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		57	86	
Gate Resistance	Rg	f = 1 MHz	0.5	1.3	2	Ω
Turn-On Delay Time	t _{d(on)}			12	24	
Rise Time	t _r	$V_{DD} = 40 \text{ V}, \text{ R}_{L} = 4 \Omega$		8	16	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 10 \text{ Å}, V_{\text{GEN}} = 10 \text{ V}, R_g = 1 \Omega$		32	64	
Fall Time	t _f			7	14	
Turn-On Delay Time	t _{d(on)}			14	28	ns
Rise Time	t _r	$V_{DD} = 40 \text{ V}, \text{ R}_{\text{I}} = 4 \Omega$		11	22	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 10$ Å, $V_{GEN} = 6.0$ V, $R_g = 1$ Ω		30	60	
Fall Time	t _f	3		8	16	-
Drain-Source Body Diode Characteristic	s			•	•	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			75	٨
Pulse Diode Forward Current (t = 100 µs)	I _{SM}				150	A
Body Diode Voltage	V _{SD}	I _S = 5 A		0.76	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			38	75	ns
Body Diode Reverse Recovery Charge	Q _{rr}			36	70	nC
Reverse Recovery Fall Time	ta	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$		19		
Reverse Recovery Rise Time	t _b			19		ns

Notes

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

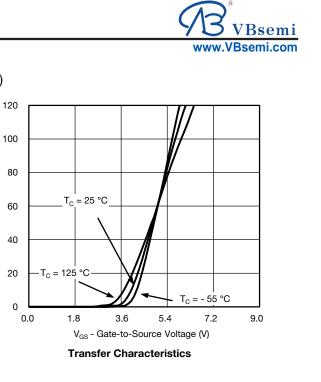
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www.

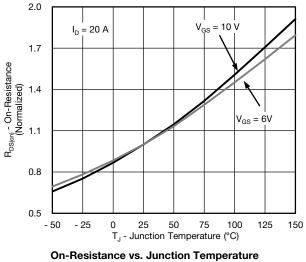
100

80

60



20 = 3 V Vce 3.0 4.0 5.0 5000 4000 C - Capacitance (pF) Coss 3000 2000 1000 C_{rss} 0 0 12 24 36 48 110 120 130 V_{DS} - Drain-to-Source Voltage (V) Capacitance



I_D - Drain Current (A) l_D - Drain Current (A) 60 40 40 20 $V_{GS} = 4 V$ 0 0.0 1.0 2.0 V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics** 0.010 0.009 $R_{DS(on)}$ - On-Resistance (Ω) 0.008 0.007 $V_{GS} = 10 V$ 0.006 0.005 0 90 100 **On-Resistance vs. Drain Current** 2.0 10 $I_{\rm D} = 10 \,{\rm A}$ V_{GS} - Gate-to-Source Voltage (V) 8 $V_{DS} = 40 V$ R_{DS(on)} - On-Resistance (Normalized) 1.1 7.1 6 $V_{DS} = 20 V$ $V_{DS} = 60 V$ 4 2 0 Q_g - Total Gate Charge (nC) 0 8 32 40 Gate Charge

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

 $V_{GS} = 6 V$

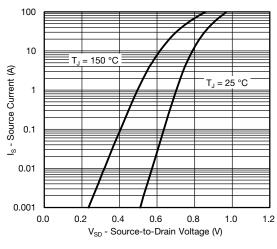
= 10 V thru 7V

60

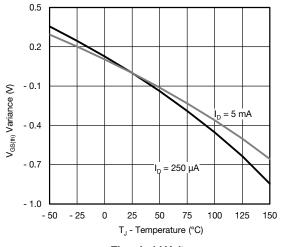




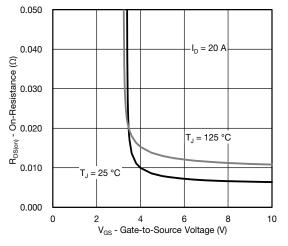




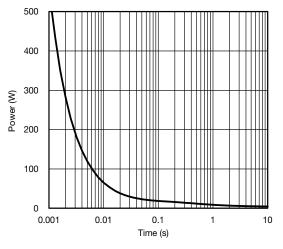
Source-Drain Diode Forward Voltage



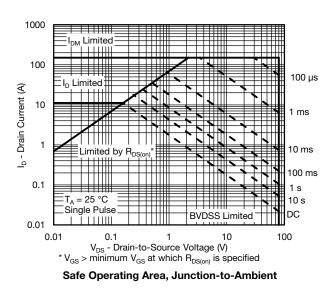




On-Resistance vs. Gate-to-Source Voltage

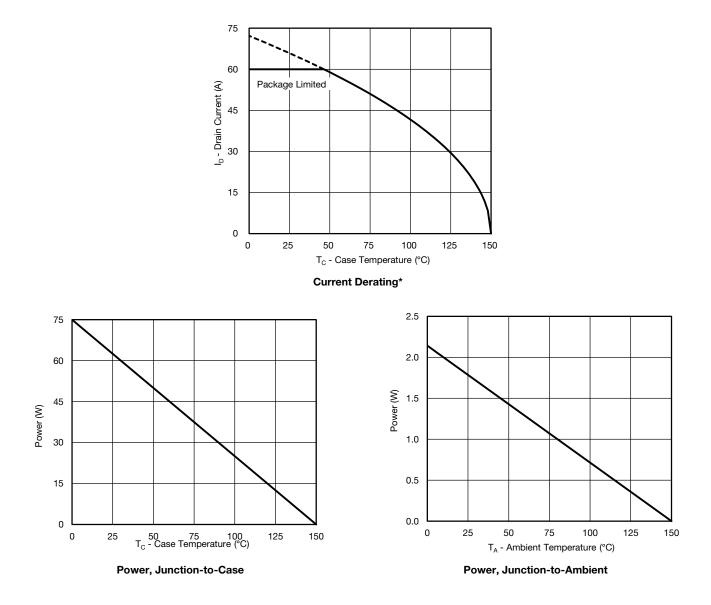


Single Pulse Power, Junction-to-Ambient





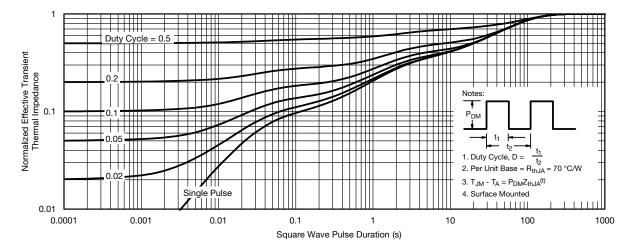
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



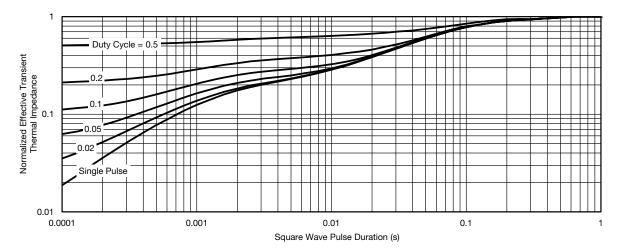
* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



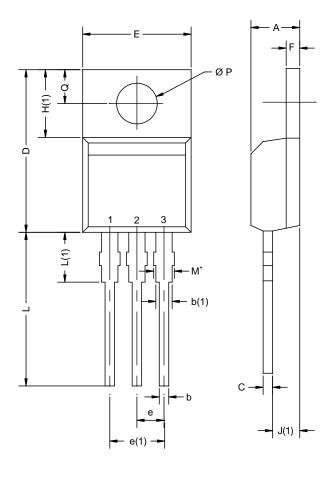
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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